

System Record Sheet—PAUT 相控阵系统记录

1. Equipment Name and Serial No. 设备名称和序列号:

Declaration of conformity No. 符合证明证书编号	Type 类型	Valid Date 有效期

2. Probe Type information 探头信息:

Probe Name and Serial No. 探头名称和序列号	
Certificate according to ISO 18563-2 No.: 探头按照 ISO 18563-2 证书编号	

3. Beam characterization and Used Block information 声束特性和采用试块:

Used channels of the instrument or used part of the array and specific settings for a given mode of operation 仪器的常用通道或阵列的常用部分以及特定操作模式的具体设置	
Block Type and serial No.: 试块类型和序列号	
Tested parameters and the settings (e. g. transmitter voltage, gain, filters) 测试参数和设置 (如发射电压、增益、滤波器)	

4. Applied standard and Frequency of checking 执行标准和测试频次

Standard used, including year of publication 执行标准及出版年份	ISO 18563-3: 2024
Frequency of checking 核查频次	1. before starting and at the end of the non-destructive testing 检测前后 () 2. daily 每天 () 3. weekly 每周 () 4. monthly 每月 ()

5. System record data according to ISO 18563-3 按照 ISO 18563-3 系统记录数据

Item 测试项目		Base values 基准值								
External aspects 外观	External aspects of the equipment 设备的外观情况 9.2									
Elements and channels 晶元和通道	Channel assignment 通道核查 9.3.2 Relative sensitivity of elements, reference amplitude and dead elements 晶元相对灵敏度、参考波幅和死晶 9.3.3 ^a									
Correct operation 运行正确	Amplification system 幅值 9.4.2 ^b Using imaging 采用图像 9.4.3 ^c () Using beams 采用声束 9.4.4 ^d () Skew angle 偏转角度 9.4.5 ^e									
	Test and clause	Mode 1	Mode 2 Example a	Mode 2 Example b	Mode 3	Mode 4	Mode 5	Mode 6	TFM mode	
	Using imaging ^a <u>9.4.3</u>	Not applicable	S-scan presentation	Not applicable	L-scan presentation	At least one L-scan or S-scan presentation	L-scan or S-scan presentation	At least three L-scan or S-scan presentations ^b	TFM image	
	Using beams ^a <u>9.4.4</u>	Used beam	At least 3 beams ^b		At least three apertures ^b	At least the three following beams: first shot of first aperture, last shot of last aperture and median shot of median aperture		At least three apertures ^b , and three beams ^b for each of these apertures	Not applicable	
	Skew angle <u>9.4.5</u>								Required if applied	
a) Verification of correct operation is either done by using imaging (9.4.3) or by using beams (9.4.4). 通过成像 (9.4.3) 或声束 (9.4.4) 验证是否正确。 b) Verifications shall be done for extreme and median beams or apertures or presentations. 必须对最大、小值和中值声束或孔径或演示进行验证。 c) For matrix array probes generating beams with skew angles, the verifications shall be performed in the extreme and median deflection planes. 对于产生偏转声束的面阵探头，应在最大偏转和中间偏转平面进行验证。										
Other 其他核查	Squint angle 偏转角度 9.5.1 ^f									
Result 结论										
Date 日期										
Operator name /level 测试人及级别										

Note:

- a. -1) $A_{\max} - A_{\min} < 50\% \text{ of FSH}$; -2) For linear array probes and matrix array probes with up to 64 elements, the dead elements shall not be adjacent. -3) For matrix array probes with more than 64 elements, each dead element shall have maximum one adjacent dead element. -4) If new dead elements are found during periodical tests, it should be verified that the reference amplitude of the affected active apertures and the signal-to-noise ratio remain acceptable for the application. -5) **Maximum number of dead elements**

Type of array probe	$0,5 < f \leq 5 \text{ MHz}$	$5 < f \leq 10 \text{ MHz}$
Linear array		1 out of 16
Matrix array with number ≤ 64 elements		
Matrix array with number > 64 elements	10 %	15 %

b. **Acceptance criteria for the linearity of summed signals**

Table 7 — Acceptance criteria for the linearity of summed signals up to 100 % of FSH

Gain setting (dB)	Expected amplitude (% of full screen height)	Limits (% of full screen height)
+ 2	101	Not less than 95
0	80	(Reference value)
- 6	40	37 to 43
- 12	20	17 to 23

Table 8 — Acceptance criteria for the linearity of summed signals above 100 % of FSH

Gain setting (dB)	Expected amplitude value (% of maximum value)	Limits (% of maximum value)
+ 2	101	Not less than 95
0	80	(Reference value)
- 6	40	37 to 43
- 12	20	17 to 23
- 18	10	8 to 12

- c. a) 1) Each indication shall be located at the probe side of the center of the hole; 2) The position of maximum amplitude shall be located in an annular band as defined in Figure 5, 3) Or the distance DCM shall be approximately equal to the radius r of the side-drilled holes.
 b) The tolerance in Figure 5 (half the width of the annular band), or the value $|DCM - r|$ shall not exceed:
 -1) For frequency $f \geq 5 \text{ MHz}$: 0,75 mm; -2) For frequency f with $2 \text{ MHz} \leq f < 5 \text{ MHz}$: 1 mm; -3) For frequency $f < 2 \text{ MHz}$: 1,25 mm.
- d. a) Probe index points shall be within $\pm 1 \text{ mm}$ of the base values. b) For angles of refraction up to 65° , the measured angles of refraction shall be within $\pm 2^\circ$ of the values specified in the settings of the delay laws. c) For angles of refraction greater than 65° , the measured angles shall be within $\pm 5^\circ$ of the specified values.
- e. The measured skew angle values shall be equal to the values specified, to $\pm 4^\circ$.
- f. Shall be equal to the value specified to $\pm 2^\circ$.